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Polariton effects in the dielectric function of ZnO excitons obtained by ellipsometry

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The complex dielectric tensor of ZnO in the regime of the excitonic transitions is determined with ellipsometry and analyzed concerning the quantization of the electromagnetic field in terms of coupled polariton-eigenmodes. Negative sections in the real part indicate the significant formation of polaritons for the dipole-allowed excitons of the three upper valence-bands $\Gamma_7, \Gamma_9, \Gamma_7$. The transverse-longitudinal splittings which separate the upper polariton branch from the lower branch, corresponding to the \mathbf{k} -vector of the used light, are deduced precisely for each subband. Mainly for $\mathbf{E} \parallel c$, additional absorption peaks are observed at the longitudinal B-exciton and closely above. One is considered to be a mixed-mode and the other is seen as a consequence of interference effects in an exciton free surface layer which is also visible in reflectance anisotropy spectroscopy. © 2010 American Institute of Physics. [doi:10.1063/1.3284656]

Apart from the potential use of ZnO for ultraviolet light emitting diodes, photodetectors or transparent conductors for solar cells, the strong excitonic binding energy ($E_b \approx 60$ meV) in combination with the polar bonding character exhibits many more interesting phenomena. The interaction with an electromagnetic wave comes along with strong polarization fields traveling through the material in terms of coupled transverse and longitudinal eigenmodes. Since the mixed state of the radiation field and polarization waves can be considered as bosonic quasiparticles, a collective condensation in the lowest quantum state (quasi Bose–Einstein condensation) at $\mathbf{k}=0$ is possible and already impressively shown by resonantly exciting them in a microcavity.¹ Using this cavity polariton condensation, polariton lasing is one of the most fascinating applications because of the extremely low threshold power operation without the need of population inversion. The wide-band gap semiconductors are favored since the strong coupling regime and the coherence state is stable at room temperature and above. Recently, GaN-based polariton lasing at room temperature has been realized.² Using ZnO as active medium, further enhancement is predicted in operating temperature and Rabi-splitting between the different modes.³ For a development of these devices,⁴ the precise knowledge of the polariton eigenstates is crucial to optimize the resonator structure. The dispersion relationship for excitonic polaritons is represented by the dipole allowed (optical) eigenstates as a function of the wave vector \mathbf{k} which basically depends on the direction of light propagation in the material regarding the crystallographic directions.⁵

The optical properties, e.g., specular reflection and absorption are governed by the index of refraction n and the extinction coefficient κ which are known as frequency dependent quantities that define the dielectric function (DF).

The group symmetry of wurtzite ZnO is C_{6v} . For a complete description of the linear optical response of this uniaxial anisotropic crystal, two independent components of the DF referring to electronic excitation parallel (ϵ_{\parallel}) and per-

pendicular (ϵ_{\perp}) to the optical c -axis have to be probed.

Ellipsometry is the method of choice because it allows a direct and reference-free determination of the whole set of linear optical functions by measuring the amplitude ratio Ψ of and the phase shift Δ between parallel and perpendicular polarized parts of the reflected light beam. The real and imaginary part of the DF are determined in a straightforward manner and approximations in a subsequent Kramers–Kronig analysis are avoided. Most of the previous work is based on either reflectivity or absorption/transmission measurements and always regarded separately without any direct association. Gaining a complete picture of the correlation between the reflectivity and the dielectric real and imaginary part is strongly desirable.

In this letter we present ellipsometric measurements of the fine structure of the A, B, and C-excitons in ZnO including a determination of the longitudinal-transverse splittings Δ_{LT} of their individual polaritons under a certain angle of incidence. All previously published ellipsometric results on ZnO, e.g.,^{6,7} could not resolve the energetic positions of A and B. Possible reasons can be either an overlayer of condensed water on the surface, if cooling in a non-UHV environment, which causes a considerable damping of structures, or from an insufficient resolution of the monochromator.

We used an a -plane bulk crystal grown by the hydrothermal method with a surface normal along the $[1\bar{1}20]$ offered by CrysTec. The XRD FWHM-value of the rocking curve using the $(11\bar{2}0)$ -reflection at $\omega=28.17^\circ$ is 135.9 arcsec and the Raman shift of the $E_2(\text{high})$ mode is recorded to be 437.4 ± 0.4 cm⁻¹, respectively. The values indicate a rather good crystal quality (for an a -plane substrate) and a small build-in compressive strain.⁸ However, this sample was chosen to be a representative material. Other bulk samples and homoepitaxial epilayers were also investigated but in this letter we do not attempt to evaluate the observed differences in the absolute values of the split subbands A and B, which relate to different internal strain levels. All measurements were performed with a rotating analyzer ellipsometer with an angle of incidence of 67° by using a normal incidence mono-

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chromator 3mNIM at BESSY II. The base pressure was kept at 3×10^{-10} mbar. The resolution of the monochromator $E/\Delta E$ is better than 10 000 and spectroscopic measurements were taken with intervals of 50 μeV . The polarization vector of the beam was tilted to 20° to the plane of incidence. The a -plane samples were oriented with the c -axis perpendicular or parallel to the plane of incidence, so that the p -polarized electric field component is $\mathbf{E}_p \perp c$ and $\mathbf{E}_p \parallel c$. In this case, the tensor components can be separated more readily with a two phase model⁹ and a correction of the so called pseudo-DF to the ordinary and extraordinary DF ε_\perp and ε_\parallel was processed by using the Fresnel formulas for uniaxial anisotropic media.¹⁰ Reflectance anisotropy spectroscopy (RAS) was performed with a home build setup in normal incidence configuration.

For the detailed description of the optical response functions closely below the band gap we consider the three excitation series which are derived from a Zn 4s-like conduction band with Γ_7 symmetry and an O 2p-like valence band. Neglecting spin, this is split into two bands of Γ_5 and Γ_1 symmetry by the hexagonal crystal field. The relativistic spin-orbit coupling lifts the degeneracy of the Γ_5 into an upper Γ_9 and a lowered Γ_7 , while the Γ_1 becomes the lowest Γ_7 . In ZnO, the spin-orbit splitting Δ_{so} is most commonly assumed to be negative due to the narrow Zn 3d level,¹¹ which is actually a closed shell core level. This enforces an overlap of their wave functions which results in a strong p - d repulsion. A reversal in the two upper valence states Γ_7 and Γ_9 is considered as a consequence. We prefer to use the reversed ordering, since magnetophotoluminescence on the hole-state related fine-splitting of bound excitons¹² strongly support this assumption. The three ground state exciton bands ($n=1$) are labeled A, B, and C in order of increasing energy. Each band is twofold degenerated for $\mathbf{k}=0$.

The ellipsometric spectra of ZnO in the vicinity of the $A\Gamma_7$, $B\Gamma_9$, and $C\Gamma_7$ at $T=10$ K is given in Figs. 1(a) and 1(c) together with (d) the RAS data and (e) the dispersion in \mathbf{k} -space calculated from Eq. (1). For an analysis it is very important to regard the interdependent relation of the real and imaginary part at distinct structures, whereas the imaginary part is directly proportional to the absorption. Because of $\nabla \varepsilon_0 \varepsilon(\omega) \mathbf{E} = 0$ and $\mathbf{E}_0 \times \mathbf{k}^{i(\mathbf{k}r - \omega t)} = 0 \Rightarrow \mathbf{E} \perp \mathbf{k}$, where ε_0 and $\varepsilon(\omega)$ are the dielectric constants in vacuum and matter, \mathbf{E} is the electric-field vector of the electromagnetic wave with a frequency ω and \mathbf{k} is the wave vector, the principal solution for light in matter (and vacuum) is a transverse electromagnetic wave. The other solution $\varepsilon(\omega) = 0$, which is only valid in matter, gives the resonance for a longitudinal mode $\mathbf{E}(\omega_L) \parallel \mathbf{k}$ with antiparallel polarization and electric field $\varepsilon_0 \mathbf{E} = -\mathbf{P}$. Because of the noncrossing rule in the region of the stop-band between ω_0 and ω_L there is only very small fraction of light propagating the sample and the penetration depth is shorter than the wavelength. We identify the transverse resonance energies $\hbar\omega_0$ by the local maxima in the imaginary part ε_2 and the longitudinal resonance $\hbar\omega_L$ by the zero crossing point toward positive values (the high energy end of the negative region) of the real part ε_1 corresponding to the Lorentz oscillator model. This allows a direct and very precise determination of both resonances ω_0 and ω_L and the transverse-longitudinal splitting Δ_{LT} . By contrast, in reflectivity measurements [see Fig. 1(c)] where finite damping causes always a considerable broadening in the spectral

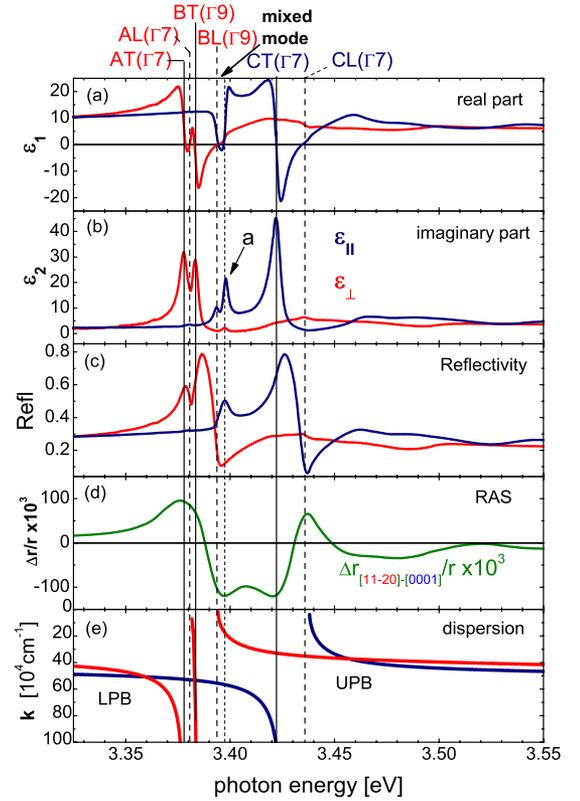


FIG. 1. (Color online) (a) Real and (b) Imaginary part of the DF and (c) Reflectivity obtained from ellipsometry, (d) RAS and (e) Dispersion relation for $n=1$ exciton-polaritons. The transversal (longitudinal) energies are marked with solid (dashed) lines. The anomaly “a” is marked with an arrow. The RAS data resemble the peaks for $\mathbf{E} \perp c$ with positive values while the peaks in $\mathbf{E} \parallel c$ are negative.

width of the stop-band, the determination of ω_0 can only be obtained by a very complicated line shape analysis.

The \mathbf{k} -dependence of our data in Fig. 1(e) was calculated for $\mathbf{k} \perp c$ by using the so-called polariton equation and the following assumption:¹³

$$\mathbf{k}^2 = \frac{n^2 \omega^2}{c^2}; \quad n^2 = \varepsilon(\omega) = \varepsilon_b \times \frac{\omega_L^2 - \omega^2}{\omega_0^2 - \omega^2}, \quad (1)$$

where ω_L and ω_0 are the longitudinal and transverse resonance frequencies and ε_b is the background dielectric constant, respectively. We obtain a ε_b^\perp of 6.69 and ε_b^\parallel of 7.47 for the excitonic region from our spectra. The longitudinal wave solution at $\mathbf{k}=0$ marks also the onset of the upper polariton branch (UPB), going over into a photonlike dispersion, while the lower polariton branch becomes excitonlike within the bottleneck-region. The strong interaction of very close lying oscillators, namely the A and B excitons in ZnO, has to be taken into account by a superposition of their resonances and shows up in a considerable distortion of the polariton branches as displayed in Fig. 1(e). This explains the fact, that the LT-splitting is strongly reduced for the A exciton, while it is increased for the B exciton-polariton (see Table I). It is therefore not possible to deduce the oscillator strength by these splittings correctly which should actually both have the same value.¹⁴

The ordinary tensor component ε_\perp was obtained by an ellipsometric measurement with \mathbf{k} in the xy -plane (normal to the c -axis), therefore oscillators with Γ_5 symmetry ($A\Gamma_7$ and $B\Gamma_9$) oriented along x and y are excited. We find a nonde-

TABLE I. Exciton-polariton parameters in ZnO obtained from ellipsometry (in electron-volt).

Exciton	Polarization	$\hbar\omega_0$	$\hbar\omega_L$	Δ_{LT}	n=2
$A\Gamma_7$	\perp	3.3778	3.3805	0.0027	3.4214
$B\Gamma_9$	\perp	3.3834	3.3940	0.0106	3.4276
$C\Gamma_7$	\parallel	3.4224	3.4345	0.0121	3.4630
Mixed mode	\parallel (weak \perp)	3.3934	3.3977	0.0043	...
Anomaly	\parallel (weak \perp)	...	3.3979

generate transverse and a longitudinal branch for $\mathbf{E}\parallel y$ and $\mathbf{E}\parallel x$, respectively. The extraordinary tensor component ε_{\parallel} was measured with the \mathbf{E} -field vector oriented 20° to the plane containing both the wave vector and the c -axis. The external angle between \mathbf{k} and c is 23° , hence \mathbf{k} can be divided into two components. For the one component $\mathbf{k}\parallel c$, only pure transverse modes are expected, while for the other component $\mathbf{k}\perp c$ and $\mathbf{E}\parallel c$ only longitudinal excitons are allowed. For angles in between, mixed-modes will appear, which have components of both transverse and longitudinal polarizations.¹⁵ As a result, the extraordinary polariton $C\Gamma_1$, which couples only to $\mathbf{E}\parallel c$, and a mixed mode polariton is observed. For the mixed mode, the absorption peak for the transverse eigenmode ω_0^{mix} exactly matches ω_L^B of the ordinary part. The value of ω_L^{mix} is again obtained by $\varepsilon_{\parallel}=0$. The LT-splitting of the mixed mode is 4.3 meV. From $\Delta_{LT}(\phi) = \Delta_{LT}(0^\circ)\cos^2\phi$, however, this could imply that the actual LT-splitting of the B exciton-polariton should be around 5.2 meV without level repulsion of the A-exciton. Regarding the additional absorption structure at ω_L^{mix} in ε_2 it is obvious that this is not consistent with the corresponding real part ε_1 when applying the Lorentz oscillator model and Kramers–Kronig relations. Owing to the effort of Hopfield, Thomas, Pekar, and Lagois^{5,16,17} there exists already a quite good understanding of the experimental findings of anomalous peaks by the involve of an exciton free surface layer (“dead layer”) in connection with additional boundary conditions (ABC) for the Maxwell equations as a consequence of spatial dispersion. We believe that this anomalous peak relates to multiple reflection interferences, which takes place in the “dead layer,” which may be thicker than the pure Bohr radius due to surface imperfections. Also, small misalignments of the c -axis can result in slight admixtures of states and the weak appearance of the mixed mode and $C_L\Gamma_7$ in ε_{\perp} and $B_L\Gamma_9$ in ε_{\parallel} is seen as a consequence. Narrow anomalous spikes due to isotropic points were also reported¹⁸ and explained by an energy transfer from one polarization to another. To address this problem, we performed RAS-measurements in the spectral region of interest [Fig. 1(d)]. The crosschecking with RAS is very useful to verify ellipsometric data for anisotropic crystals.¹⁹ The RAS gives the amount of anisotropy by the ratio of the difference of reflectivity parallel and perpendicular $\Delta r_{[11\bar{2}0]-[0001]}$ and the total reflectivity. At isotropic points of the optical functions, where ε_{\perp} and ε_{\parallel} are equal, the RAS signal is zero. It is assumed, that a residual surface induced anisotropy (e.g., reconstructions) is absent or negligible. The RAS measurements were performed at almost normal incidence, therefore the mixed mode is expected to disappear. Indeed the mixed branch vanishes but the anomaly does not. It again does not coincide with the isotropic points. It has to be noticed, that the RAS spectrum was recorded at

$T=120$ K, hence the A and B structures are not resolved and the corresponding structures are subsequently shifted about 9 meV to higher energies.

In summary, the presented study shows the possibility of precise determination of the LT-splitting for every individual exciton-polariton with ellipsometry for a certain angle of incidence. The most interesting features found in the spectra are the negative sections in ε_1 and anomalous absorption peaks in ε_2 . From the classical Lorentz oscillator model we identify the longitudinal eigenfrequency usually by a vanishing ε and the transverse by maxima in the absorption, but the anomalous peak closely above B_L does not satisfy to this description. This peak correlates to the zero crossing of ε_1 of a mixed mode. Within our observations, it turns out that one cannot neglect the effects of strong coupling when using ellipsometry and RAS in the spectral region of strong excitonic absorption. The suggested description of optical response only manipulates the “effective” optical parameters, therefore additional structures near excitonic resonances in the spectra do not reduce the utility of Kramers–Kronig consistency. The next step is to verify the “dead layer” assumption with a suitable model fit by taking ABC explicitly into account.

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